Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10516428	CHI ET AL.
Examiner	Art Unit

1644

SEARCHED				
Class	Subclass	Date	Examiner	

Michael Szperka

SEARCH NOTES		
Search Notes	Date	Examiner
updated inventor search in eDAN; Chi, Francis; Lu, Tian(shui)	9/17/08	MS
updated USPAT USPGPUB EPO JPO DERWENT (EAST) see search printouts	9/17/08	MS

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

	/Michael Szperka/ Primary Examiner.Art Unit 1644
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